

FORM PTO-1449 (SUBSTITUTE) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE INFORMATION DISCLOSURE STATEMENT BY APPLICANT (37 CFR 1.98(b))				Attorney Docket No.: P2001,0119 Appl. No.: <u>10/650055</u> Applicant: BERNHARD SELL ET AL. Filing Date: August 26, 2003 Group Art Unit: <u>2813</u>			
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EXAMINER INITIALS	PATENT NO.	DATE	PATENTEE	CLASS	SUB CLASS	FILING DATE
<i>RL</i>	A	4,589,193	5/20/86	Goth et al.		
<i>RL</i>	B	5,905,279	5/18/99	Nitayama et al.		
<i>RL</i>	C	5,760,434	6/2/98	Zahurak et al.		
<i>RL</i>	D	5,262,343	11/16/93	Rhodes et al.		
<i>RL</i>	E	2002/0125521 A1	9/12/02	Schrems		
	F					
	G					
	H					
	I					

FOREIGN PATENT DOCUMENT							
DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB CLASS	TRANSL. YES NO		
<i>RL</i>	J	0 967 643 A2	12/29/99	Europe			
<i>RL</i>	K	0 981 164 A2	2/23/00	Europe			
<i>RL</i>	L	0 495 991 A1	7/29/92	Europe			
<i>RL</i>	M	01/20681 A1	3/22/01	WIPO			
<i>RL</i>	N	01/17014 A1	3/8/01	WIPO			

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)	
<i>RL</i>	Alperin, M. E. et al.: "Development of the Self-Aligned Titanium Silicide Process for VLSI Applications", IEEE Journal of Solid-State Circuits, Vol. SC-20, No. 1, February 1985, pp. 61-69
<i>RL</i>	Yamada, K. et al.: "A Deep-Trenched Capacitor Technology for 4 Mega Bit Dynamic Ram", IEEE, IEDM 85, 29.3, pp. 702-705

EXAMINER <i>Harvey Schuler</i>	DATE CONSIDERED <u>2/6/05</u>
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EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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FOREIGN PATENT DOCUMENT							
		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB CLASS	TRANSL. YES NO
<i>JS</i>	J	63062371	3/18/88	Japan			
	K						
	L						
	M						
	N						
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)							
EXAMINER <i>Nareea Schuly</i>				DATE CONSIDERED <i>2/6/05</i>			
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